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| Notice of References Cited | Application/Control No. 09/574,647 | Applicant(s)/Patent Under Reexamination VAN DOORN, SCHELTO | |
| | Examiner Edwin A. León | Art Unit 2833 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification | |
|---|---|--|-----------------|----------------|----------------|-----|
| | A | US-5,432,758- | 07-1995 | Sone | 367 | 175 |
| | B | US-5,408,373- | 04-1995 | Bajorek et al. | 360 | 104 |
| | C | US-4,345,299- | 08-1982 | Ho | 361 | 283 |
| | D | US- - | | | | |
| | E | US- - | | | | |
| | F | US- - | | | | |
| | G | US- - | | | | |
| | H | US- - | | | | |
| | I | US- - | | | | |
| | J | US- - | | | | |
| | K | US- - | | | | |
| | L | US- - | | | | |
| | M | US- - | | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification | |
|---|---|--|-----------------|---------|------|----------------|--|
| | N | - - | | | | | |
| | O | - - | | | | | |
| | P | - - | | | | | |
| | Q | - - | | | | | |
| | R | - - | | | | | |
| | S | - - | | | | | |
| | T | - - | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
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